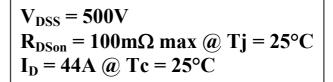
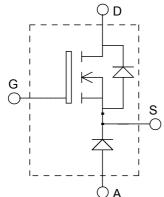
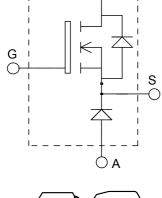


ISOTOP® Buck chopper MOSFET Power Module







Application

- AC and DC motor control
- Switched Mode Power Supplies

Features

- Power MOS V® MOSFETs
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Fast intrinsic diode
 - Avalanche energy rated
 - Very rugged
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Very rugged
- Low profile
- **RoHS Compliant**

Absolute maximum ratings

ISOTOP®

Symbol	Parameter			Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage			500	V
T	Continuous Drain Current $ \frac{T_c = 25^{\circ}C}{T_c = 80^{\circ}C} $		44		
I_D			33	Α	
I_{DM}	Pulsed Drain current			176	
V_{GS}	Gate - Source Voltage			±30	V
R _{DSon}	Drain - Source ON Resistance			100	mΩ
P_D	Maximum Power Dissipation		$T_c = 25$ °C	450	W
I_{AR}	Avalanche current (repetitive and non repetitive)			44	A
E_{AR}	Repetitive Avalanche Energy			50	mJ
E_{AS}	Single Pulse Avalanche Energy	2500	1113		
IF_{AV}	Maximum Average Forward Current	Duty cycle=0.5	$Tc = 80^{\circ}C$	30	Α
IF_{RMS}	RMS Forward Current (Square wave, 5	50% duty)	·	39	A

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 500V$ $T_j = 25^{\circ}C$			25	μА
		$V_{GS} = 0V, V_{DS} = 400V$ $T_j = 125^{\circ}C$			250	
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 22A$			100	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 2.5 \text{mA}$	2		4	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		7410		
C_{oss}	Output Capacitance	$V_{DS} = 25V$		1050		pF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		390		
Q_{g}	Total gate Charge	$V_{GS} = 10V$		312		
Q_{gs}	Gate – Source Charge	$V_{Bus} = 250V$ $I_D = 44A @ T_J = 25^{\circ}C$		37		nC
Q_{gd}	Gate – Drain Charge			127		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = 15V$ $V_{Bus} = 250V$		18		
$T_{\rm r}$	Rise Time			16		ma
$T_{d(off)}$	Turn-off Delay Time	$I_D = 44A @ T_J = 25^{\circ}C$		54		ns
T_{f}	Fall Time	$R_G = 0.6\Omega$		5		

Chopper diode ratings and characteristics

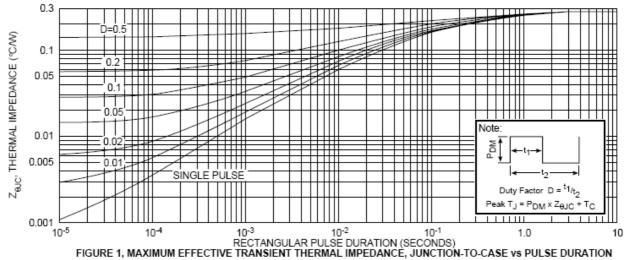
Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{F}	Diode Forward Voltage	$I_F = 30A$			1.6	1.8	
		$I_F = 60A$			1.9		V
		$I_F = 30A$	$T_i = 125$ °C		1.4		
I_{RM}	Maximum Reverse Leakage Current	$V_{R} = 600V$	$T_i = 25$ °C			250	μA
1RM	Waximum Reverse Leakage Current	$V_R = 600V$	$T_{i} = 125^{\circ}C$		500	500	μΑ
C_T	Junction Capacitance	$V_R = 200V$			44		pF
_	Reverse Recovery Time	$I_F=1A, V_R=30V$ di/dt =100A/\(\mu\)s	$T_j = 25$ °C		23		ns
t_{rr}	Reverse Recovery Time		$T_i = 25$ °C		85		
		$T_i = 125$ °C		160			
I_{RRM}	Maximum Reverse Recovery Current	$I_F = 30A$	$T_j = 25$ °C		4		Α
1RRM	Widamidin Reverse Recovery Current	$V_R = 400V$	$T_{i} = 125^{\circ}C$		8		Λ
0	Reverse Recovery Charge	$di/dt = 200A/\mu s$	$T_j = 25$ °C		130		nC
Q_{rr}			$T_j = 125$ °C		700		IIC
t_{rr}	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$			70		ns
Q_{rr}	Reverse Recovery Charge		$T_j = 125$ °C		1300		nC
I_{RRM}	Maximum Reverse Recovery Current				30		A



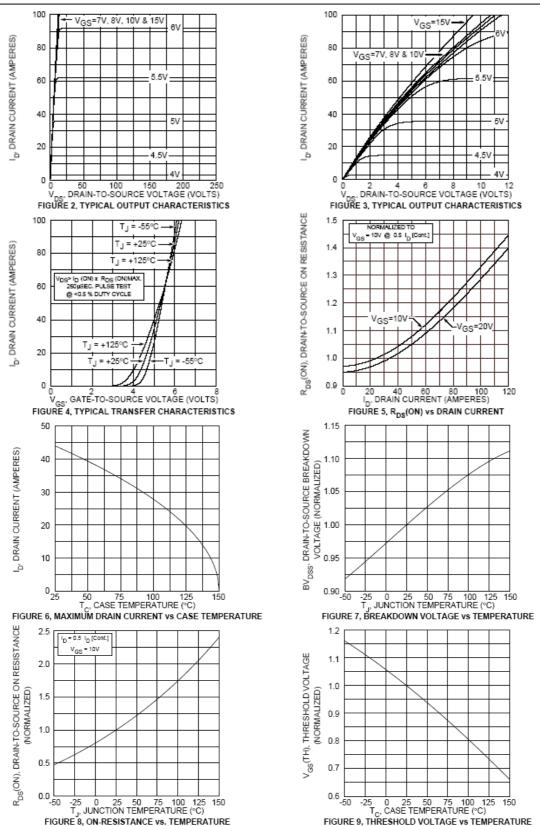
Thermal and package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit	
R_{thJC}	Junction to Case Thermal Resistance	MOSFET			0.28		
		Diode			1.21	°C/W	
R_{thJA}	Junction to Ambient (IGBT & Diode)				20		
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz		2500			V	
T_{J}, T_{STG}	Storage Temperature Range		-55		150	°C	
$T_{ m L}$	Max Lead Temp for Soldering:0.063" from case for 10 sec				300	300	
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m	
Wt	Package Weight			29.2		g	

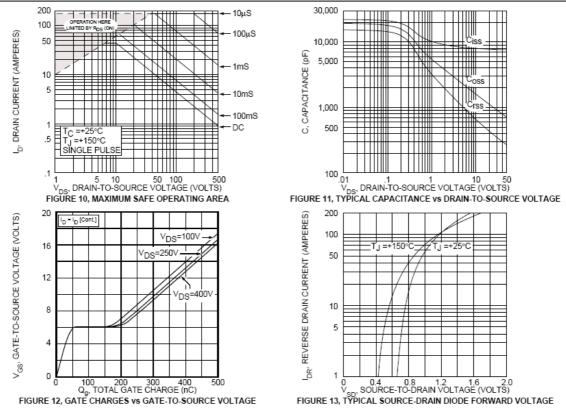
Typical MOSFET Performance Curve



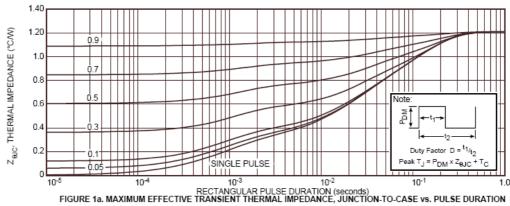








Typical Diode Performance Curve



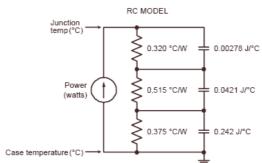


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL



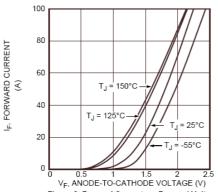


Figure 2. Forward Current vs. Forward Voltage

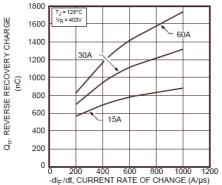


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

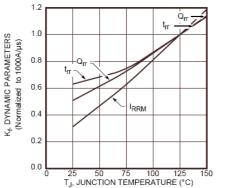


Figure 6. Dynamic Parameters vs. Junction Temperature

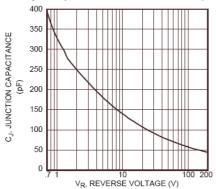


Figure 8. Junction Capacitance vs. Reverse Voltage

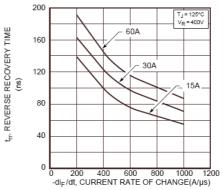


Figure 3. Reverse Recovery Time vs. Current Rate of Change

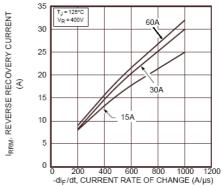


Figure 5. Reverse Recovery Current vs. Current Rate of Change

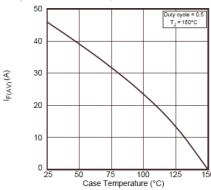


Figure 7. Maximum Average Forward Current vs. CaseTemperature



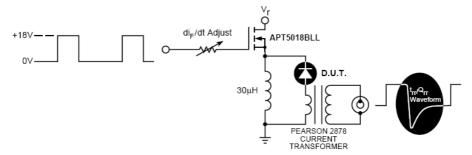
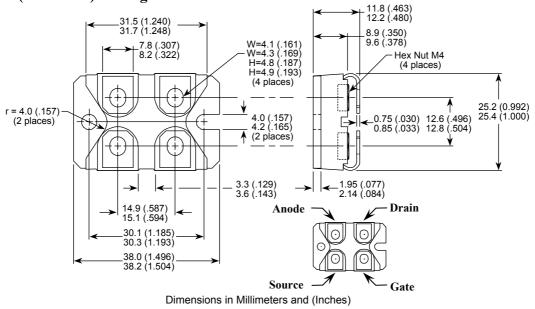


Figure 9. Diode Test Circuit

I_F - Forward Conduction Current
 di_F/dt - Rate of Diode Current Change Through Zero Crossing.
 I_{RRM} - Maximum Reverse Recovery Current.
 t_{IT} - Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I_{RRM} and 0.25 • I_{RRM} passes through zero.
 Q_{IT} - Area Under the Curve Defined by I_{RRM} and t_{IT}.

Figure 10, Diode Reverse Recovery Waveform and Definitions

SOT-227 (ISOTOP®) Package Outline



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